

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/613,912	<b>Applicant(s)/Patent under Reexamination</b> CHATTERJEE, CHANCHAL
	<b>Examiner</b> David H. Malzahn	<b>Art Unit</b> 2193

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner